Notice of References Cited Application/Control No. 10/075,492 Examiner Paul R. Myers Applicant(s)/Patent Under Reexamination DENG ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,471,674	11-1995	Stewart et al.	713/2
*	В	US-5,555,416	09-1996	Owens et al.	717/178
*	С	US-6,430,635	08-2002	Kwon et al.	710/104
*	D	US-2002/0078339	06-2002	Hung-Ju et al.	713/2
*	E	US-6,330,634	12-2001	Fuse et al.	711/103
*	F	US-5,070,474	12-1991	Tuma et al.	703/24
*	G	US-6,055,631	04-2000	Chadha, Tejpal S.	713/2
*	Н	US-5,822,184	10-1998	Rabinovitz, Josef	361/685
*	-	US-5,319,751	06-1994	Garney, John I.	711/115
*	J	US-4,541,019	09-1985	Precourt, Normand E.	360/15
*	к	US-6,453,414	09-2002	Ryu, Chang-Hyun	713/2
*	L	US-5,717,886	02-1998	Miyauchi, Shigenori	711/103
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 628908 A1	12-1994	European Patent	BEDINGFIELD et al.	G06F 09/445
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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